

<b>Notice of References Cited</b>	Application/Control No. 10/041,760		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Jamie Vent		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2001/0028655	10-2001	Noda et al.	370/402
*	C	US-6,456,783	09-2002	Ando et al.	386/125
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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